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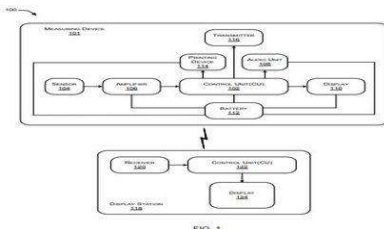
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(57) Abstract :

A system for measuring weight of sample of material is disclosed. The system can include a measuring device. The measuring device can include a scoop configured to receive and hold a sample; one or more sensors, operatively coupled to said scoop, configured to sense one or more attributes of said sample and generate one or more signals based on said one or more attributes of said sample; and characterized in that, a transmitter configured to transmit said one or more generated signals; and a first display unit operatively coupled with said measuring device such that said first display unit is dissociated from said measuring device, wherein said first display unit is configured to display one or more values corresponding to said one or more transmitted signals received by a receiver operatively coupled with said first display unit.



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